

EAST Search History

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|-------|------|--|----------|------------------|---------|------------------|
| L15 | 17 | ((wafer or semiconductor or substrate) (hypothetical or calculated or expected or estimated) diffraction profile).clm. | US-PGPUB | SAME | ON | 2008/02/19 15:19 |
| L17 | 9 | ((hypothetical or calculated or expected or estimated) diffraction spacing).clm. | US-PGPUB | SAME | ON | 2008/02/19 15:20 |
| L19 | 1 | ((wafer or semiconductor or substrate) locations diffraction cost).clm. | US-PGPUB | SAME | ON | 2008/02/19 15:22 |
| L20 | 3 | ((wafer or semiconductor or substrate) locations diffraction (cost or fit or match or tolerance)).clm. | US-PGPUB | SAME | ON | 2008/02/19 15:22 |

2/19/2008 3:24:06 PM

C:\Documents and Settings\Rslomski\My Documents\EAST\Workspaces\10
663300 Hypprofile wafer sample index.wsp